Shu–Validation et al. Shu–Discovery et al. Byeon et al.	-3.3310 -0.7950 0.0652	0.6893 0.4261 0.3087			+			-0.79	[ -4.68; -1.9 [ -1.63; 0.0 [ -0.54; 0.6	4] 34.0%
Random effects model Prediction interval					<b>\rightarrow</b>				[ -3.21; 0.66] [-25.61; 23.06]	_
2			-20	-10	0	10	20			
Heterogeneity: $I^2 = 90\%$ ,	<i>p</i> < 0.01									

SMD SE(SMD)

Study

**Standardised Mean** 

**Difference** 

SMD

95%-CI Weight